## Indian Institute of Technology Patna MA-225: B.Tech. II year Spring Semester: 2018-19 Mid Semester Examination

Maximum Marks: 30

Total Time: 2 Hours

[1]

Note: Answer all eight questions. You can use scientific calculator.

- 1. Consider the function  $f_X(x) = b(2x x^3)$ ,  $0 < x < \frac{2}{5}$ , otherwise 0. Then find b so that it is a valid density function. Also compute the conditional probability  $P(X < 0.2 \mid X > 0.1)$ . [1+2]
- 2. A large lot of tires contains 5% defectives. Suppose 4 good tires are to be chosen from the lot for a car. Determine the probability of finding at least 2 defective tires before 4 good ones are selected. Compute the expected number of defective tires before finding 4 good tires. Compute the moment generating function of the corresponding distribution. (derive expressions for mean and mgf)
- 3. Let X be a random variable which represents the height of a group of population in a city. Suppose that X has mean value 129 cm and standard deviation 19.8 cm. Using the Chebyshev inequality, obtain a lower bound on the probability that height of this population will take values between 89.4 and 168.6 cm. Further if this X is normally distributed then obtain the corresponding probability in terms of the standard normal CDF.

  [1.5+1.5]
- 4. (a) State and prove the Bayes theorem.

  (b) Is it possible that an event is independent of its 162 to 162.
  - (b) Is it possible that an event is independent of itself? If so, when is this the case?
- 5. The future lifetime X for a particular product can be described using the probability function  $P(X > x) = e^{-(x/5)^3}$  for x > 0, otherwise 0; also x is measured in years. Compute the expected life of such a product. Determine the conditional probability that a product will survive less than 10 years given that it is in working condition for more than 5 years. [2+3]
- 6. A batch of 100 printed circuit cards is populated with semiconductor chips. Assume that this batch contains 20 defective cards. Now if a random sample of 10 circuit cards is taken out from the batch without replacement for function testing. Then write probability mass function of X (hypergeometric variable) which denotes the number of defective cards in the selected sample. Determine the probability of getting at least 2 defective circuit cards in the sample. Compute this probability using the binomial random variable approximation. [1+2+2]
- 7. Le X follow a normal distribution with both mean and variance being 2. Then find the cumulative distribution function of -1.5X 0.5. Also obtain the corresponding moment generating function. Properly write required steps in both the cases. [2+2]
- 8. Three horses x, y and z enter in a race. If an outcome of the form yxz means that y finishes first, x second and z third then write the sample space. Consider the event A as 'x finishes before y' and B as 'x finishes before z'. Do events A and B form a partition of the sample space.

  [1+1]